



Drain

pin 2

Source

pin 3

AIMW120R045M1

CoolSiC[™] 1200V SiC Trench MOSFET

Silicon Carbide MOSFET

Features

- Revolutionary semiconductor material Silicon Carbide
- Very low switching losses
- Threshold-free on state characteristic
- IGBT-compatible driving voltage (15V for turn-on)
- 0V turn-off gate voltage
- Benchmark gate threshold voltage, V_{GS(th)}=4.5V
- Fully controllable dv/dt
- Commutation robust body diode, ready for synchronous rectification
- Temperature independent turn-off switching losses

Benefits

- Efficiency improvement
- Enabling higher frequency
- Increased power density
- Cooling effort reduction
- Reduction of system complexity and cost

Potential Applications

- On-board Charger/PFC
- Booster/DC-DC Converter
- Auxilliary Inverter

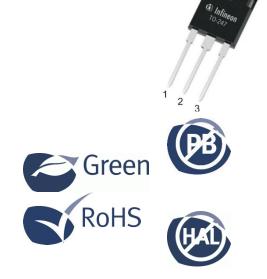
Product Validation

Qualified for Automotive Applications. Product Validation according to AEC-Q100/101"

Table 1 Key Performance and Package Parameters

Туре	V _{DS}	I D (Tc=25°C, <i>R</i> th(j-c,max))	R _{DS(on),typ} (<i>T</i> _{vj} =25°C, <i>I</i> _D =20A, <i>V</i> _{GS} =15V)	T _{vjmax}	Marking	SP Number	Package
AIMW120R045M1	1200V	52A	45mΩ	175°C	A120M1045	SP002472666	PG-TO247-3-41





Gate

pin 1



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1 Maximum ratings

Table 2 Maximum ratings¹

Parameter	Symbol	Value	Unit
Drain-source voltage, <i>T</i> _{vj} ≥ 25°C	V _{DSS}	1200	V
DC drain current for $R_{\text{th(j-c,max)}}$, limited by T_{vjmax} , V_{GS} =15V			
$T_{\rm C} = 25^{\circ}{\rm C}$	<i>I</i> D	52	A
$T_{\rm C} = 100^{\circ}{\rm C}$		36	
Pulsed drain current, t_p limited by T_{vjmax} , $V_{GS} = 15V$	I D,pulse ¹	130	А
DC body diode forward current for $R_{th(j-c,max)}$, limited by			
T _{vjmax} , V _{GS} =0V	1		Δ
$T_{\rm C} = 25^{\circ}{\rm C}$	Isd	52	A
$T_{\rm C} = 100^{\circ}{\rm C}$		28	
Pulsed body diode current, t_p limited by T_{vjmax}	<i>I</i> sD,pulse ¹	68	A
Gate-source voltage ²			
Max transient voltage, < 1% duty cycle	V _{GSS}	-7 20	v
Recommended turn-on gate voltage	V GSS,on	15	
Recommended turn-off gate voltage	V GSS,off	0	
Power dissipation, limited by <i>T</i> _{vjmax}			
$T_{\rm C} = 25^{\circ}{\rm C}$	P _{tot}	228	W
<i>T</i> _C =100°C		114	
Virtual junction temperature	T _{vj}	-40175	°C
Storage temperature	T _{stg}	-55150	°C
Soldering temperature,			
wavesoldering only allowed at leads,	T _{sold}	260	°C
1.6mm (0.063 in.) from case for 10 s			
Mounting torque, M3 screw	Λ <i>Λ</i>	0.6	Nm
Maximum of mounting processes: 3	М	0.6	Nm

¹ Not subject to production test. Parameter verified by design/characterization.

² **Important note:** The selection of positive and negative gate-source voltages impacts the long-term behavior of the device. The design guidelines described in <u>Application Note AN2018-09</u> must be considered to ensure sound operation of the device over the planned lifetime.

AIMW120R045M1 CoolSiC™ 1200V SiC Trench MOSFET



Thermal resistances

2 Thermal resistances

Table 3Thermal resistances1

Deromotor	Symbol	Conditions	Value			Unit	
Parameter	Symbol	Conditions	min. typ. max.				
MOSFET/body diode thermal resistance, junction – case	R th(j-c)		-	0.51	0.66	K/W	
Thermal resistance, junction – ambient	R _{th(j-a)}	leaded	-	-	62	K/W	

¹ Not subject to production test. Parameter verified by design/characterization.

Electrical Characteristics



3 **Electrical Characteristics**

3.1 Static characteristics

Table 4 Static characteristics (at T_{vj} =25°C, unless otherwise specified)

Demension	Cumphed	umbel Conditions		Value			
Parameter	Symbol	Conditions	min.	typ.	max.	- Unit	
Drain-source on-state		<i>V</i> _{GS} =15V, <i>I</i> _D =20A,					
resistance ²	D	$T_{\rm vj} = 25^{\circ}{\rm C}$	-	45	59	mΩ	
	R _{DS(on)}	$T_{\rm vj}$ = 100°C	-	55	-	11122	
		<i>T</i> _{vj} = 175°C	-	75	-		
		$V_{\rm GS}$ = 0V, $I_{\rm SD}$ =20A					
Body Diode forward voltage	V _{SD}	$T_{\rm vj} = 25^{\circ}{\rm C}$	-	4.1	5.2	v	
	VSD	<i>T</i> _{vj} =100°C	-	4.0	-	V	
		<i>T</i> _{vj} =175°C	-	3.9	-		
		(tested after 1 ms pulse at					
Gate-source threshold	V _{GS(th)}	V_{GS} =+20 V) I_{D} = 10mA, V_{DS} = V_{GS}				v	
voltage ²		$T_{\rm vj} = 25^{\circ}{\rm C}$	3.5	4.5	5.7		
		<i>T</i> _{vj} =175°C	-	3.6	-		
7		$V_{\rm GS} = 0V, V_{\rm DS} = 1200V$					
Zero gate voltage drain current	I _{DSS}	T _{vj} =25°C	-	2	200	μA	
current		<i>T</i> _{vj} =175°C	-	50	-		
		$V_{\rm GS} = 20 V$, $V_{\rm DS} = 0 V$	-	-	120	nA	
Gate-source leakage current	I _{GSS}	$V_{\rm GS}$ = -10V, $V_{\rm DS}$ = 0V	-	-	-120	nA	
Transconductance	g _{fs}	$V_{\rm DS} = 20 V, I_{\rm D} = 20 A$	-	11.1	-	S	
Internal gate resistance	R G,int	$f = 1$ MHz, $V_{AC} = 25$ mV	-	4.5	-	Ω	

² Important note: The selection of positive and negative gate-source voltages impacts the long-term behavior of the device. The design guidelines described in Application Note AN2018-09 must be considered to ensure sound operation of the device over the planned lifetime.

AIMW120R045M1 CoolSiC™ 1200V SiC Trench MOSFET

Electrical Characteristics



3.2 Dynamic characteristics

Table 5Dynamic characteristics (at $T_{vj}=25^{\circ}C$, unless otherwise specified)

Demonstern	C	O and the second	Value			11	
Parameter	Symbol	Symbol Conditions		typ.	max.	Unit	
Input capacitance	Ciss			2130			
Output capacitance	Coss	$V_{DS} = 800V, V_{GS} = 0V, f = 1MHz,$		107	_	pF	
Reverse capacitance	Crss	$V_{\rm AC} = 25 {\rm mV}$	-	11	-		
Coss stored energy	Eoss			44		μJ	
Total gate charge	Q _G			57			
Gate to source charge	Q _{GS,pl}	$V_{DD} = 800V, I_D = 20A,$	-	19	-	nC	
Gate to drain charge	Q _{GD}	$V_{\rm GS} = 0/15$ V, turn-on pulse		13			
Short-circuit withstand time ³	t _{sc}	$V_{DD} = 800V, L_{\sigma} = 80nH,$ $R_{G,ext} = 90hm, T_{vj} = 175^{\circ}C$ $V_{GS.on} = 15V$	-	3	-	μs	

³ Verified by design for single short circuit event at $V_{GS,on} = 15V$.

Electrical Characteristics



3.3 Switching characteristics

Table 6 Switching characteristics, Inductive load ⁴

Dementer	Course had	Conditions		Value		11	
Parameter	Symbol	hbol Conditions min.		typ.	max.	Unit	
MOSFET Characteristics	, <i>Τ</i> _{νj} =25°C						
Turn-on delay time	t _{d(on)}		-	9	-	ns	
Rise time	<i>t</i> r	$V_{\rm DD}$ =800V, $I_{\rm D}$ =20A,	-	32	-	ns	
Turn-off delay time	t _{d(off)}	$V_{\rm GS}=0V/15V, R_{\rm G,ext}=2\Omega,$	-	17	-	ns	
Fall time	t _f	L_{σ} =40nH, diode: body diode at V_{GS} =0V see Fig. E	-	13	-	ns	
Turn-on energy	Eon		-	450	-	μJ	
Turn-off energy	Eoff		-	70	-	μJ	
Total switching energy	E _{tot}	- 300 Hg. L	-	520	-	μJ	
Body Diode Characterist	ics, T _{vj} =25°C			·			
Diode reverse recovery charge	Q _{rr}	$V_{DD} = 800V, I_{SD} = 20A,$ V_{GS} at diode=0V, $d_{f}/$	-	0.15	-	μC	
Diode peak reverse recovery current	<i>I</i> _{rrm}	d <i>t</i> =1000A/µs, <i>Q</i> _{rr} includes also <i>Q</i> _c , see Fig. C	-	8	-	A	

MOSFET Characteristics	, <i>T</i> _{vj} =175°C					
Turn-on delay time	t _{d(on)}		-	9	-	ns
Rise time	tr	$V_{\rm DD}$ =800V, $I_{\rm D}$ =20A,	-	32	-	ns
Turn-off delay time	$t_{\rm d(off)}$	$V_{\rm GS}=0V/15V, R_{\rm G,ext}=2\Omega,$ $L_{\sigma}=40\rm{nH},$	-	20	-	ns
Fall time	<i>t</i> _f		-	14	-	ns
Turn-on energy	Eon	diode: body diode at $V_{GS}=0V$,	-	490	-	μJ
Turn-off energy	E _{off}	v _{GS} =0V, see Fig. E	-	75	-	μJ
Total switching energy	E _{tot}	00011912	-	565	-	μJ

Body Diode Characteristics, *T*_{vj}=175°C

Diode reverse recovery charge	Q _{rr}	$Q_{\rm rr} \qquad \begin{array}{ c c } V_{\rm DD} = 800V, I_{\rm SD} = 20A, \\ V_{\rm GS} \text{ at diode} = 0V, di_{\rm f}/ \end{array}$		0.25	-	μC
Diode peak reverse recovery current	I rrm	d <i>t</i> =1000A/µs, <i>Q</i> _{rr} includes also <i>Q</i> _c , see Fig. C	-	10	-	A

⁴ The chip technology was characterized up to 200 kV/ μ s. The measured d*v*/d*t* was limited by measurement test setup and package.



Electrical characteristic diagrams

4 Electrical characteristic diagrams

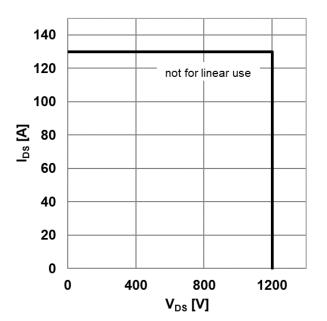
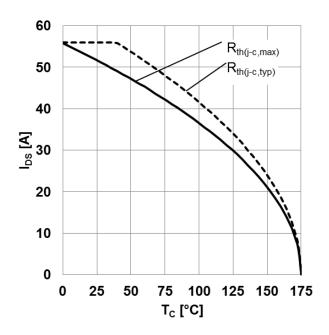


Figure 1 Reverse bias safe operating area (RBSOA) ($V_{gs} = 0/15V$, $T_c = 25^{\circ}C$, $T_i < 175^{\circ}C$)



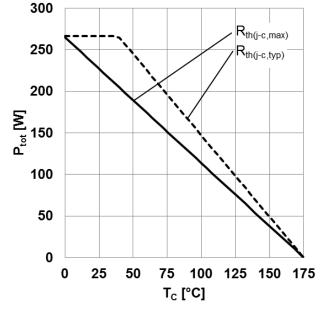


Figure 2 Power dissipation as a function of case temperature limited by bond wire $(P_{tot}=f(T_c))$

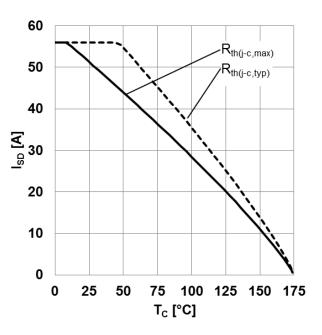
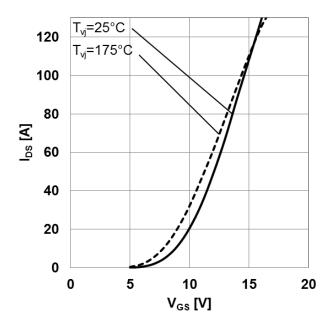


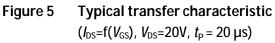
Figure 3 Maximum DC drain to source current as Figure 4 a function of case temperature limited by bond wire $(I_{DS}=f(T_C))$

Maximum source to drain current as a function of case temperature limited by bond wire $(I_{SD}=f(T_C), V_{GS}=0V)$

8







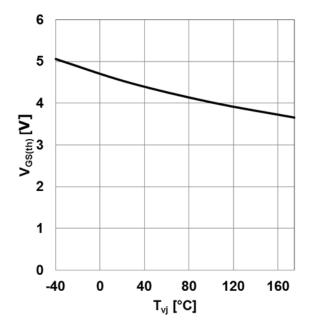


Figure 6 Typical gate-source threshold voltage as a function of junction temperature $(V_{GS(th)}=f(T_{vj}), I_{DS}=10\text{mA}, V_{GS}=V_{DS})$

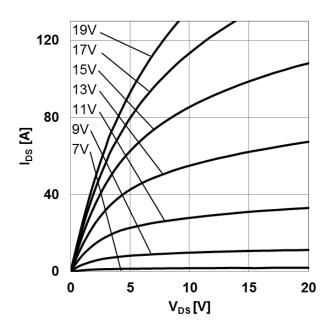
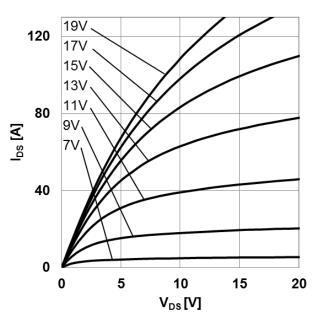


Figure 7Typical output characteristic, V_{GS} as
parameter ($I_{DS}=f(V_{DS})$, $T_{vj}=25^{\circ}C$, $t_p = 20 \ \mu s$)Figure 8



Typical output characteristic, V_{GS} as parameter ($I_{DS}=f(V_{DS})$, $T_{VJ}=175$ °C, $t_P = 20$ µs)



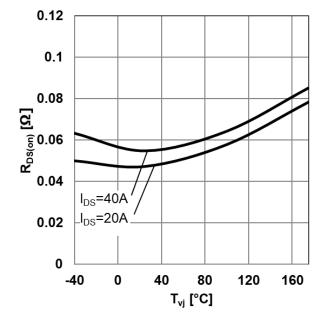


Figure 9 Typical on-resistance as a function of junction temperature $(R_{DS(on)}=f(T_{vj}), V_{GS}=15V)$

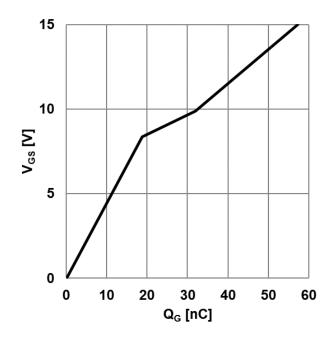


Figure 10 Typical gate charge (V_{GS} =f(Q_G), I_{DS} =20A, V_{DS} =800V, turn-on pulse)

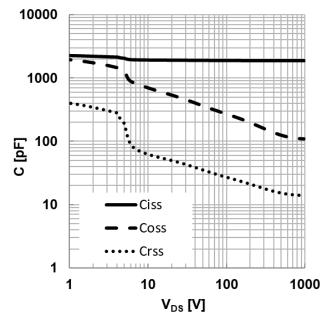


Figure 11 Typical capacitance as a function of drain-source voltage (C=f(V_{DS}), V_{GS}=0V, f=1MHz)

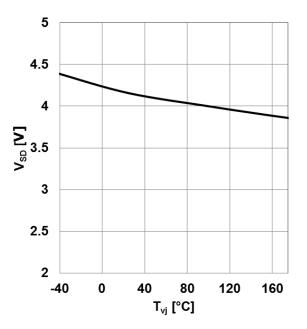
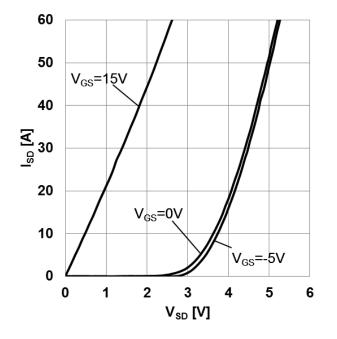
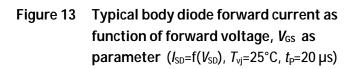


Figure 12 Typical body diode forward voltage as function of junction temperature $(V_{SD}=f(T_{vj}), V_{GS}=0V, I_{SD}=20A)$

AIMW120R045M1 CoolSiC[™] 1200V SiC Trench MOSFET Electrical characteristic diagrams







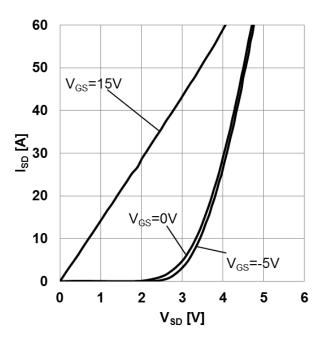
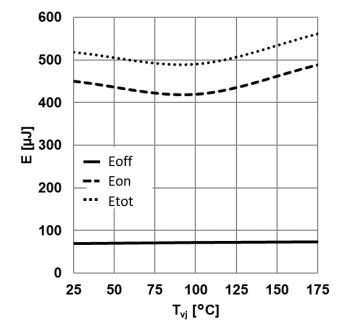
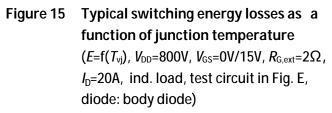


Figure 14 Typical body diode forward current as function of forward voltage, V_{GS} as parameter (I_{SD} =f(V_{SD}), T_{vj} =175°C, t_p =20 µs)





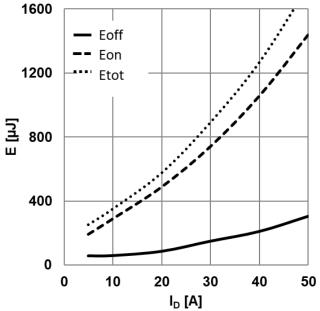


Figure 16 Typical switching energy losses as a function of drain-source current $(E = f(I_{DS}), V_{DD} = 800V, V_{GS} = 0V/15V,$ $R_{G,ext} = 2\Omega, T_{vj} = 175^{\circ}C$, ind. load, test circuit in Fig. E, diode: body diode)

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Electrical characteristic diagrams

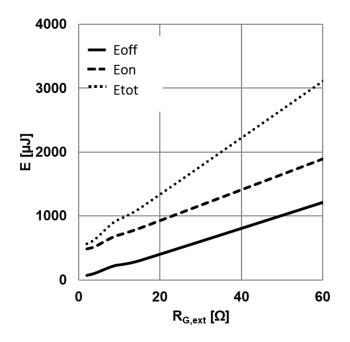


Figure 17 Typical switching energy losses as a function of gate resistance ($E=f(R_{G,ext})$, $V_{DD}=800V$, $V_{GS}=0V/15V$, $I_D=20A$, $T_{vj}=175^{\circ}C$, ind. load, test circuit in Fig. E, diode: body diode)

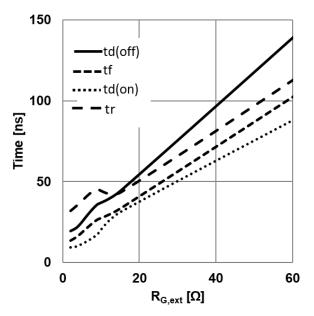
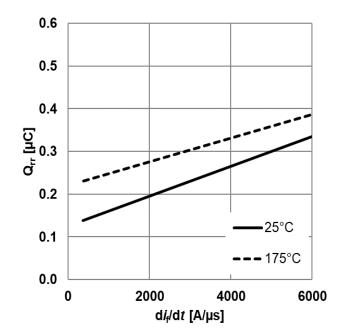
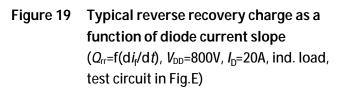


Figure 18Typical switching times as a function of
gate resistor ($t=f(R_{G,ext})$, $V_{DD}=800V$,
 $V_{GS}=0V/15V$, $I_D=20A$, $T_{Vj}=175^{\circ}C$, ind. load,
test circuit in Fig. E, diode: body diode)





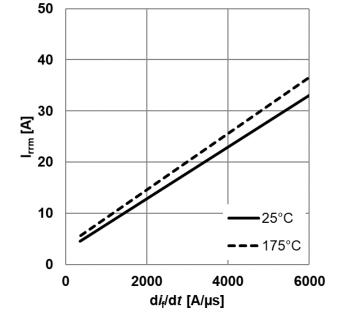


Figure 20 Typical reverse recovery current as a function of diode current slope $(I_{rrm}=f(di_{f'}/dt), V_{DD}=800V, I_{D}=20A, ind. load, test circuit in Fig.E)$





Electrical characteristic diagrams

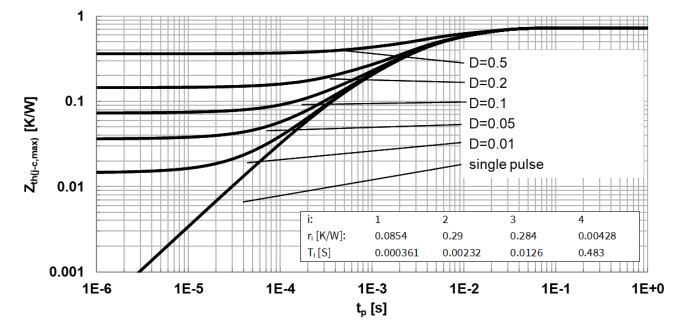


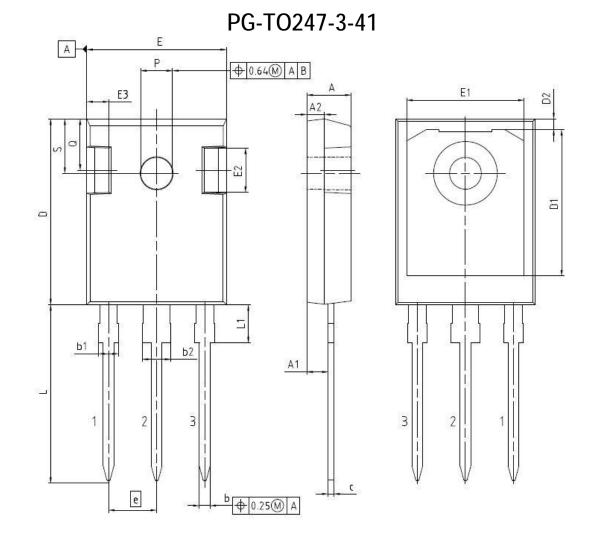
Figure 21 Max. transient thermal resistance (MOSFET/diode) $(Z_{\text{th(j-c,max)}} = f(t_p), \text{ parameter } D = t_p/T, \text{ thermal equivalent circuit in Fig. D})$

Package drawing



5

Package drawing



DIMENCIONE	MILLIM	IETERS	
DIMENSIONS -	MIN.	MAX.	
A	4.70	5.30	
A1	2.20	2.60	
A2	1.50	2.50	
b	1.00	1.40	
b1	1.60	2.41	DOCUMENT NO.
b2	2.57	3.43	Z8B00003327
C	0.38	0.89	REVISION
D	20.70	21.50	06
D1	13.08	17.65	
D2	0.51	1.35	SCALE 3:1
E	15.50	16.30	0 1 2 3 4 5mm
E1	12.38	14.15	
E2	3.40	5.10	
E3	1.00	2.60	EUROPEAN PROJECTION
e	5.	44	
L	19.80	20.40	
L1	3.85	4.50	
P	3.50	3.70	
Q	5.35	6.25	ISSUE DATE
S	6.04	6.30	25.07.2018

Figure 22 Package drawing

AIMW120R045M1 CoolSiC™ 1200V SiC Trench MOSFET

Test conditions



6

Test conditions

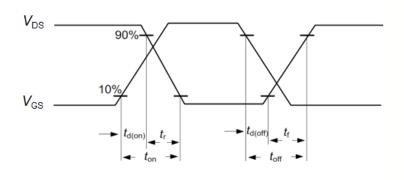
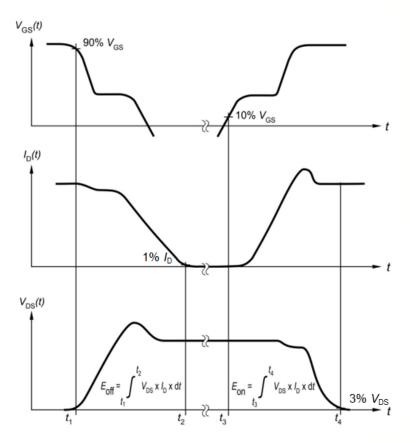
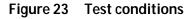


Figure A. Definition of switching times







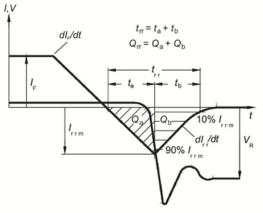


Figure C. Definition of diode switching characteristics

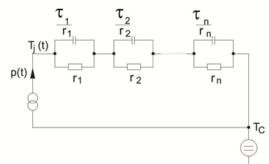


Figure D. Thermal equivalent circuit

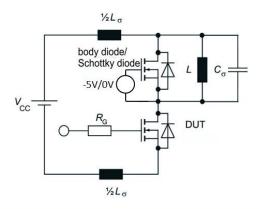


Figure E. Dynamic test circuit Parasitic inductance L_{σ} , parasitic capacitor C_{σ} ,

Revision History



Revision History

Major changes since the last revision

Page or Reference	Description of change
All pages	First release of datasheet V3.0
Page 3	I _{SD,pulse} value adjusted

Trademarks

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